

**Search Notes****Application/Control No.**

10/555,104

**Examiner**

ANH H. DO

**Applicant(s)/Patent under  
Reexamination**

CHEN ET AL.

**Art Unit**

2624

**SEARCHED**

Class	Subclass	Date	Examiner
382	103, 147, 149, 312	9/12/2009	AD
514	12		
375	240.12		
348	E5.042,		
	126, 87		
378	21, 22,		
	4, 137		
250	358.1		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US) EAST (EPO, JPO) EAST (US-PG PUB) NPL (IEEE)	9/12/2009	AD